TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC4017BP,TC4017BF

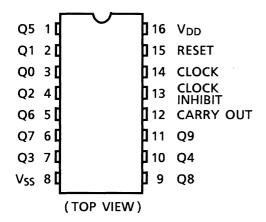
# TC4017BP/TC4017BF Decade Counter/Divider

TC4017BP/BF is decimal Johnson counter consisting of 5 stage D-type flip-flop equipped with the decoder to convert the output to decimal.

Depending on the number of count pulses fed to CLOCK or CLOCK INHIBIT one output among 10 output lines "Q0" through "Q9" becomes "H" level.

The counter advances its state at rising edge of CLOCK (CLOCK INHIBIT = "L") or falling edge of CLOCK INHIBIT (CLOCK = "H"). RESET input to "H" level resets the counter to Q0 = "H" and Q1 through Q9 = "L" regardless of CLOCK and CLOCK INHIBIT.

# **Pin Assignment**



# TC4017BP Image: Constraint of the system DIP16-P-300-2.54A TC4017BF Image: Constraint of the system SOP16-P-300-1.27A Weight DIP16-P-300-2.54A SOP16-P-300-1.27A Weight DIP16-P-300-2.54A SOP16-P-300-1.27A

# **Truth Table**

	Selected				
CLOCKA	CLOCK INHIBIT∆	RESET	Output		
*	*	Н	Q0		
*	Н	L	Qn (NC)		
L	*	L	Qn (NC)		
	L	L	Qn + 1		
$\rightarrow$	L	L	Qn (NC)		
н		L	Qn (NC)		
Н		L	Qn + 1		

 $\Delta :$  Level change

\*: Don't care

NC: No change

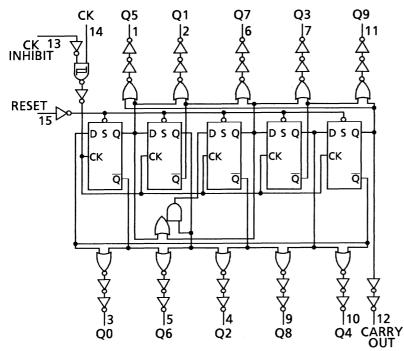
carry out { "H"...........Q0 to Q4 = "H" "L"......Q5 to Q9 = "H"

Start of commercial production 1978-04

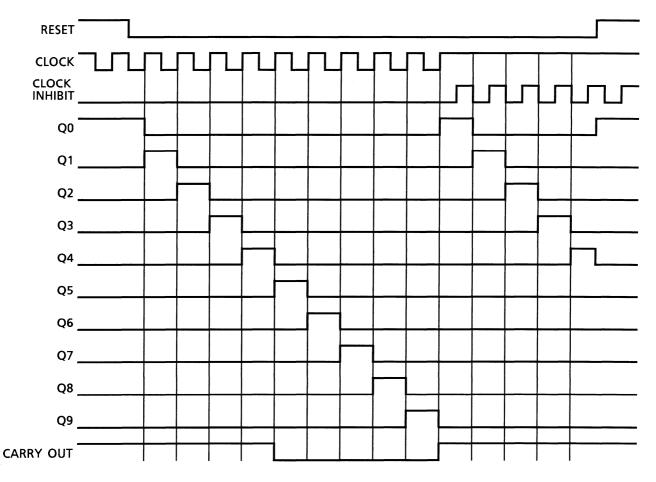
2014-03-01

# **TOSHIBA**

# Logic Diagram



# **Timing Chart**



# **Absolute Maximum Ratings (Note)**

Characteristics	Symbol	Rating	Unit
DC supply voltage	V <sub>DD</sub>	$V_{SS}$ – 0.5 to $V_{SS}$ + 20	V
Input voltage	V <sub>IN</sub>	$V_{\mbox{\scriptsize SS}}-0.5$ to $V_{\mbox{\scriptsize DD}}+0.5$	V
Output voltage	V <sub>OUT</sub>	$V_{\mbox{\scriptsize SS}}-0.5$ to $V_{\mbox{\scriptsize DD}}+0.5$	V
DC input current	I <sub>IN</sub>	±10	mA
Power dissipation	PD	300 (DIP)/180 (SOP)	mW
Operating ambient temperature range	T <sub>opr</sub>	-40 to 85	°C
Storage temperature range	T <sub>stg</sub>	–65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

# **Operating Ranges (V<sub>SS</sub> = 0 V) (Note)**

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
DC supply voltage	V <sub>DD</sub>	—	3	_	18	V
Input voltage	V <sub>IN</sub>	—	0		V <sub>DD</sub>	V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{DD}$  or  $V_{SS}$ .

# Static Electrical Characteristics ( $V_{SS} = 0 V$ )

Characteristics Symbol		Svm-	Test Condition		-40°C		25°C			85°C		
			V <sub>DD</sub> (V)	Min	Max	Min	Тур.	Max	Min	Max	Unit	
			< 1 A	5	4.95	_	4.95	5.00	_	4.95	_	
High-level voltage	output	VOH	I <sub>OUT</sub>   < 1 μΑ	10	9.95	—	9.95	10.00	—	9.95		V
0			$V_{IN} = V_{SS}, V_{DD}$	15	14.95	_	14.95	15.00	_	14.95	—	
			I <sub>OUT</sub>   < 1 μΑ	5	—	0.05		0.00	0.05	_	0.05	
Low-level voltage	output	V <sub>OL</sub>	$V_{IN} = V_{SS}, V_{DD}$	10	—	0.05		0.00	0.05	—	0.05	V
Ū			VIN - VSS, VDD	15		0.05	—	0.00	0.05	—	0.05	
			V <sub>OH</sub> = 4.6 V	5	-0.61	—	-0.51	-1.0	—	-0.42	—	
			$V_{OH} = 2.5 V$	5	-2.50	—	-2.10	-4.0	—	-1.70	—	
Output hig	h current	IOH	V <sub>OH</sub> = 9.5 V	10	-1.50	—	-1.30	-2.2	—	-1.10	—	mA
			V <sub>OH</sub> = 13.5 V	15	-4.00	—	-3.40	-9.0	—	-2.80	—	
			$V_{IN}=V_{SS},V_{DD}$									
		I <sub>OL</sub>	$V_{OL} = 0.4 V$	5	0.61	—	0.51	1.5	—	0.42	—	mA
	/ current		$V_{OL} = 0.5 V$	10	1.50	—	1.30	3.8	—	1.10	—	
Output low current	IOL	V <sub>OL</sub> = 1.5 V	15	4.00	—	3.40	15.0	—	2.80	—		
			$V_{IN} = V_{SS}, V_{DD}$									
		V <sub>IH</sub>	$V_{OUT} = 0.5 V, 4.5 V$	5	3.5	—	3.5	2.75	—	3.5	—	v
Input high	voltage		V <sub>OUT</sub> = 1.0 V, 9.0 V	10	7.0	—	7.0	5.50	—	7.0	—	
mparmgn	voltage		$V_{OUT} = 1.5 V, 13.5 V$	15	11.0	—	11.0	8.25	—	11.0	—	
			$ I_{OUT}  < 1 \ \mu A$									
		VIL	$V_{OUT} = 0.5 V, 4.5 V$	5	—	1.5		2.25	1.5	—	1.5	V
Input low voltage	V <sub>OUT</sub> = 1.0 V, 9.0 V		10	—	3.0		4.50	3.0	—	3.0		
input low voltage			$V_{OUT} = 1.5 V, 13.5 V$	15	—	4.0	—	6.75	4.0	—	4.0	
			$ I_{OUT}  < 1 \ \mu A$									
Input	"H" level	Ι <sub>ΙΗ</sub>	V <sub>IH</sub> = 18 V	18	—	0.1	_	10 <sup>-5</sup>	0.1	_	1.0	μA
current	"L" level	١	$V_{IL} = 0 \ V$	18		-0.1		-10 <sup>-5</sup>	-0.1	_	-1.0	μΛ
Quiescent supply current		IDD	V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub> (Note)	5	—	5		0.005	5	_	150	
				10	—	10		0.010	10	—	300	μA
			(	15		15		0.015	20	—	600	

Note: All valid input combinations.

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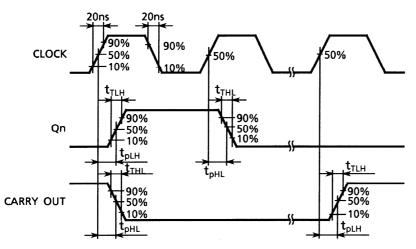
# Dynamic Electrical Characteristics (Ta = $25^{\circ}$ C, V<sub>SS</sub> = 0 V, C<sub>L</sub> = 50 pF)

Characteristics	Cumhal	Test Condition		Min	Тур.	Max	Unit
Characteristics	Symbol		V <sub>DD</sub> (V)	Min		Max	
Output transition time			5	_	80	200	
(low to high)	t <sub>TLH</sub>	—	10		50	100	ns
(low to high)			15		40	80	
Output transition time			5	_	80	200	
(high to low)	t <sub>THL</sub>	—	10	—	50	100	ns
(high to low)			15	—	40	80	
Propagation delay time	t		5		325	650	
(CLOCK-Qn)	t <sub>pLH</sub>	—	10	—	135	270	ns
	tpHL		15		85	170	
Propagation delay time	t		5		280	600	
(CLOCK-CARRY OUT)	t <sub>pLH</sub>	—	10	—	110	250	ns
(CLOCK-CARRY OUT)	tpHL		15	—	75	160	
Propagation delay time	<b>+</b>		5	_	265	530	
RESET-Qn	t <sub>pLH</sub>	—	10	—	115	230	ns
RESET-CARRY OUT	tpHL		15	—	85	170	
	fcL	_	5	2.5	6.0	_	
Max clock frequency			10	5.0	12.0	—	MHz
			15	6.7	13.5	—	
		_	5	_	85	200	ns
Min clock pulse width	tw		10	—	40	90	
			15	—	35	60	
Min nulae width			5		50	260	
Min pulse width	t <sub>WH</sub>	—	10	_	20	110	ns
(RESET)			15	—	15	60	
May alaak riga tima			5				
Max clock rise time	t <sub>rCL</sub>	—	10		No limit		μS
Max clock fall time	t <sub>fCL</sub>		15				
Min oct up time			5	_	30	230	
Min set-up time	tsu	—	10		15	100	ns
(CLOCK INHIBIT-CLOCK)			15		10	70	
Min romoval time			5		-55	400	
Min removal time	t <sub>rem</sub>	—	10		-20	275	ns
(RESET-CLOCK)			15	—	-15	150	
Input capacitance	C <sub>IN</sub>	_	•	_	5	7.5	pF

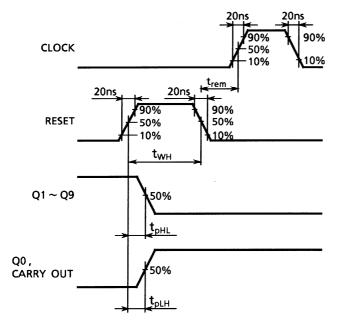
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# Waveforms for Measurement of Dynamic Characteristics

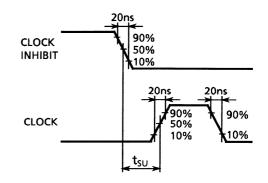
### Waveform 1



### Waveform 2



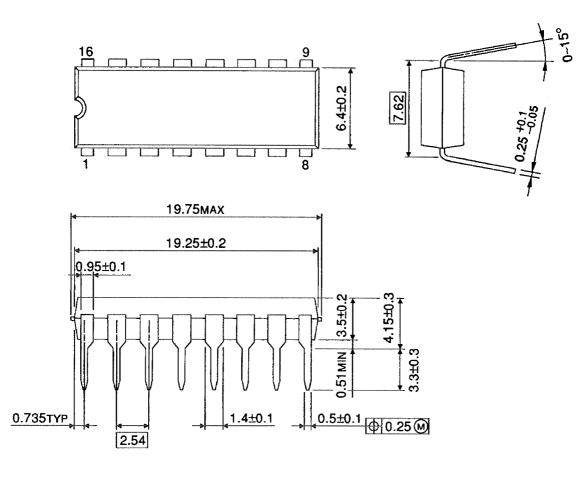
Waveform 3



# **Package Dimensions**

DIP16-P-300-2.54A

Unit : mm



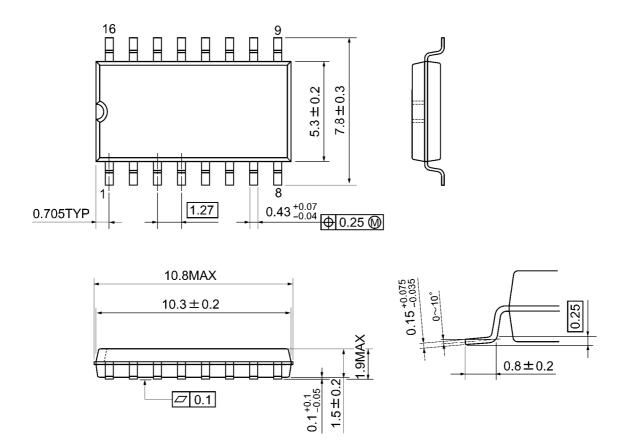
Weight: 1.00 g (typ.)



# **Package Dimensions**

SOP16-P-300-1.27A

Unit: mm



Weight: 0.18 g (typ.)

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